

<b>Notice of References Cited</b>	Application/Control No. 10/784,488	Applicant(s)/Patent Under Reexamination WEN ET AL.	
	Examiner Douglas S. Lee	Art Unit 2125	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,957,116	10-2005	Tsai et al.	700/109
*	B	US-5,050,088	09-1991	Buckler et al.	700/96
*	C	US-6,564,113	05-2003	Barto et al.	700/99
*	D	US-6,731,998	05-2004	Walser et al.	700/99
*	E	US-7,092,775	08-2006	Nomoto et al.	700/97
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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